

Vishay Siliconix

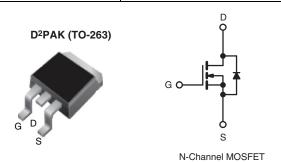
RoHS

COMPLIANT

HALOGEN

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	100			
R _{DS(on)} (Ω)	$V_{GS} = 5.0 \text{ V}$	0.16		
Q _g (Max.) (nC)	28			
Q _{gs} (nC)	3.8			
Q _{gd} (nC)	14			
Configuration	Single			



FEATURES

• Halogen-free According to IEC 61249-2-21 **Definition**



- Available in Tape and Reel
- · Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Logic Level Gate Drive

- Compliant to RoHS Directive 2002/95/EC

FREE R_{DS(on)} Specified at V_{GS} = 4 V and 5 V 175 °C Operating Temperature

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D²PAK (TO-263) is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on resistance in any existing surface mount package. The D²PAK (TO-263) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

ORDERING INFORMATION					
Package	D ² PAK (TO-263)	D ² PAK (TO-263)			
Lead (Pb)-free and Halogen-free	-	SiHL530STRR-GE3 ^a			
Lead (Pb)-free	-	IRL530STRRPbFa			
	-	SiHL530STR-E3 ^a			
SnPb	IRL530S	-			
	SiHL530S	-			

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	100	V	
Gate-Source Voltage			V_{GS}	± 10	V	
Continuous Drain Current	V _{GS} at 5 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	l _D	15		
				11	Α	
Pulsed Drain Current ^a			I _{DM}	60		
Linear Derating Factor				0.59	W/°C	
Linear Derating Factor (PCB Mount) ^e				0.025	VV/ C	
Single Pulse Avalanche Energy ^b			E _{AS}	290	mJ	
Repetitive Avalanche Current ^a			I _{AR}	15	Α	
Repetitive Avalanche Energy ^a			E _{AR}	8.8	mJ	
Maximum Power Dissipation	T _C =	25 °C	ם	88	w	
Maximum Power Dissipation (PCB Mount)e	T _A =	25 °C	P_{D}	3.7		
Peak Diode Recovery dV/dtc	<u> </u>			5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for	10 s	300 ^d		7	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=25$ V, starting $T_J=25$ °C, L = 1.9 mH, $R_g=25$ Ω , $I_{AS}=15$ A (see fig. 12). c. $I_{SD}\leq 15$ A, $dI/dt\leq 140$ A/µs, $V_{DD}\leq V_{DS}$, $T_J\leq 175$ °C. d. 1.6 mm from case.

- When mounted on 1" square PCB (FR-4 or G-10 material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRL530S, SiHL530S

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Maximum Junction-to Ambient (PCB	R _{thJA}	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	100	-	-	V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.14	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = \	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	2.0	٧	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10 V		-	-	± 100	nA	
Z. o Osla Vallaca Buis O and	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V		-	-	25	μА	
Zero Gate Voltage Drain Current		V _{DS} = 80 V, \	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 150 °C		-	250		
5 . 6 . 6 . 6	В	V _{GS} = 5.0 V	I _D = 9.0 A ^b	-	-	0.16		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	I _D = 7.5 A ^b	-	-	0.22	Ω	
Forward Transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 9.0 A ^b		6.4	-	-	S	
Dynamic								
Input Capacitance	C _{iss}	,	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		930	-	pF	
Output Capacitance	C _{oss}	V			250	-		
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	57	-		
Total Gate Charge	Q_g			-	-	28	nC	
Gate-Source Charge	Q_{gs}	V _{GS} = 5.0 V	$I_D = 15 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.8		
Gate-Drain Charge	Q_{gd}	see lig. 6 and 13-		-	-	14	1	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 50 \text{ V, } I_D = 15 \text{ A,}$ $R_g = 12 \Omega, \ R_D = 32 \Omega, \ \text{see fig. } 10^b$		-	4.7	-	- ns	
Rise Time	t _r			-	100	-		
Turn-Off Delay Time	t _{d(off)}			-	22	-		
Fall Time	t _f			-	48	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	ъU	
Internal Source Inductance	L _S			-	7.5	-	- nH	
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	15	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	60		
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 15 A, V _{GS} = 0 V ^b		-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 15 A, dI/dt = 100 A/μs ^b		-	150	200	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.93	1.4	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn	n-on is do	minated	by L c and	412)		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 μs ; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

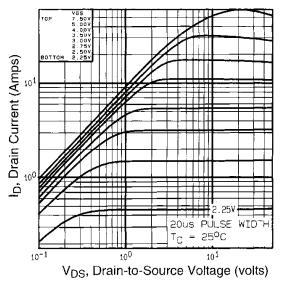


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

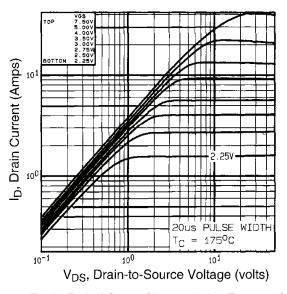


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

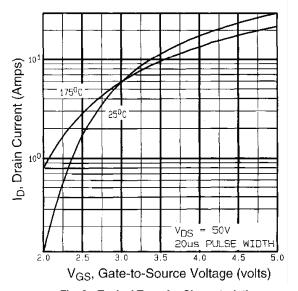


Fig. 3 - Typical Transfer Characteristics

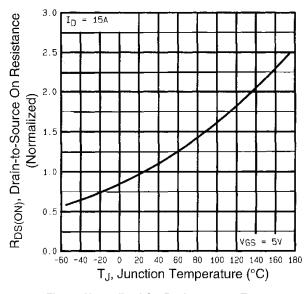


Fig. 4 - Normalized On-Resistance vs. Temperature

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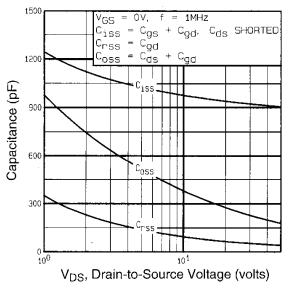


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

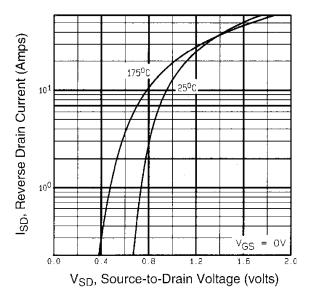


Fig. 7 - Typical Source-Drain Diode Forward Voltage

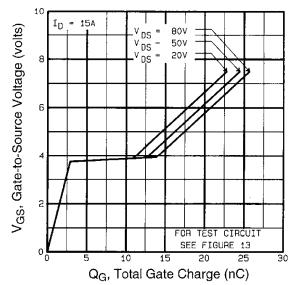


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

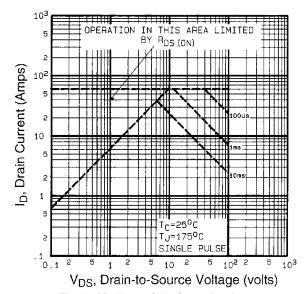


Fig. 8 - Maximum Safe Operating Area





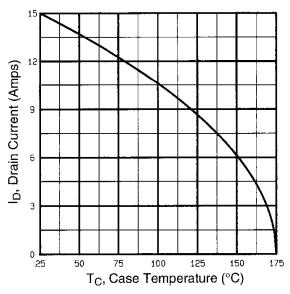


Fig. 9 - Maximum Drain Current vs. Case Temperature

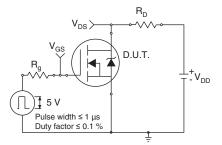


Fig. 10a - Switching Time Test Circuit

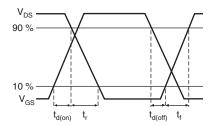


Fig. 10b - Switching Time Waveforms

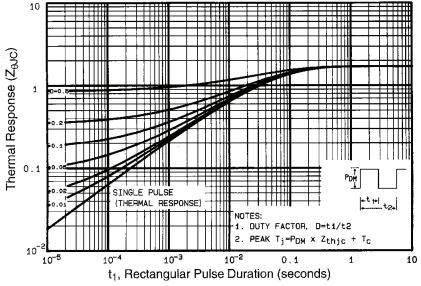


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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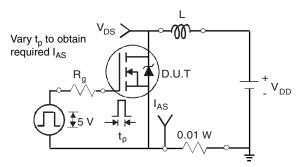


Fig. 12a - Unclamped Inductive Test Circuit

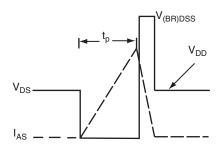


Fig. 12b - Unclamped Inductive Waveforms

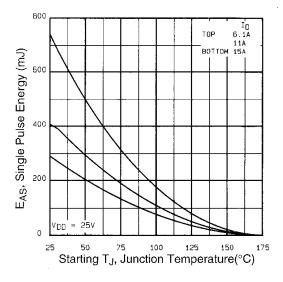


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

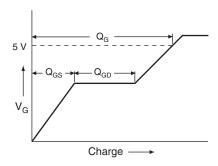


Fig. 13a - Basic Gate Charge Waveform

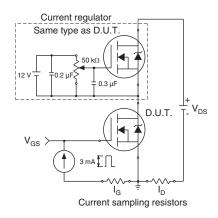
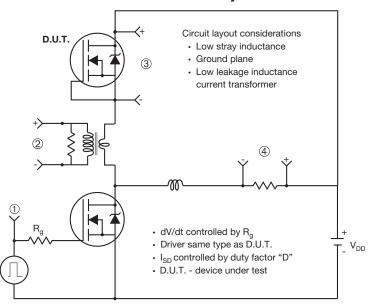


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



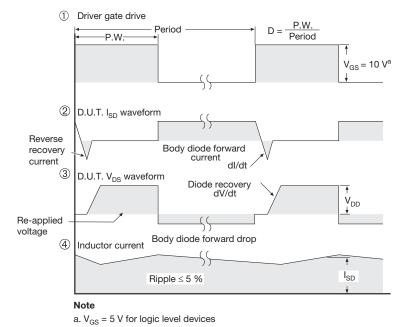


Fig. 14 - For N-Channel

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